J-1100

CD Spectrometer

Specifications



[Hardware]	
Light source:	150 W air-cooled Xenon lamp
Detector:	Head-on photomultiplier tube PMT
Monochromator:	Double-prism monochromator, Czerny-Turner mount
Modulator:	Photoelastic modulator
Measurement wavelength range:	180 to 600 nm
Wavelength accuracy:	± 0.2 nm from 180 to 250 nm, ± 0.4 nm from 250 to 500 nm ± 0.8 nm from 500 to 600 nm
Wavelength repeatability:	± 0.05 nm from 180 to 500 nm, ± 0.1 nm from 500 to 600 nm
Spectral bandwidth:	1 nm
Slit width:	1 to 4000 μm
Digital Integration Time (D.I.T.):	8 msec. to 8 sec.
Scanning mode:	Continuous scan, Step scan, Auto response (D.I.T) scan
Scanning speed:	up to 5000 nm/min (when using continuous scan)
Photometric Mode:	CD, LD, Transmittance, Absorbance, HT voltage, DC voltage, External input (Temperature, PH, etc. are available)
CD full scale:	±8000 mdeg
CD resolution:	0.00001 mdeg
Wavelength resolution:	0.025 nm (when using continuous scan)
Stray light:	Not more than 0.0003% (at 200 nm)
RMS noise:	0.03 mdeg (at 200 nm, at 500 nm, D.I.T. 8 sec)
Baseline stability:	0.05 mdeg/hr
LD measurement:	Full scale ±1ΔOD / Resolution 0.000001ΔOD
UV measurement:	Single beam measurement / Photometric range: 0 to 5 Abs Photometric accuracy: ±0.01 Abs (0 to 1 Abs, checked using NIST SRM 930 filter)
External input terminal:	Two channels (input range: -1 to 1 V DC)

Mercury lamp	Used for the instrument inspection
Shutter	Located the light source unit
Standard cell holder:	CH-434 cylindrical/rectangular cell holder
Available cells	: Cylindrical cell: Optical pathlength 0.1 to 20 mm, O.D. 22 mm Rectangular cell: Optical pathlength 1 to 20 mm, optical pathwidth 10 mm
Sample chamber:	105 (W) $ imes$ 150 (D) $ imes$ 110 (H) mm, Exists the water inlet/outlet ports
Dimensions/Weight:	740 (W) × 545 (D) × 325 (H) mm, 70 kg
Power requirements:	AC 100 to 240 V, 50/60 Hz, 360 VA
[Data processing]	
Software:	JASCO Spectra Manager Ver. 2.5 ^{*1}
Operating system:	Windows [®] 11 Pro
CD data processing:	CD K-K transform, HT-OD conversion, CPL calculation, G value calculation, Sample Information edition, ORD-E Data correction, Optical constant calculation, Error bar view, r-P transform, pH axis transform
Standard program:	Spectra Measurement, Time Course Measurement, Interval Scan Measurement, Data Monitor, Validation, JASCO Canvas, Spectra Analysis, Interval Data Analysis, MCD Hysteresis Analysis, ORDE-521 Data Correction
	Variable Temperature Measurement ^{*2} , Temperature Interval Scan Measurement ^{*2} , Temperature/Wavelength Scan Measurement ^{*2}
Optional program:	qHOS program, BeStSel program, Denaturation analysis (includes Thermal denaturation multi analysis), Analog output module (non-CFR only), Macro command (non-CFR only)
[Installation requirement]	
Operation temperature/humidity:	15 to 30 °C, less than 85 %
Nitrogen gas purging:	Light source unit, monochromator unit, and sample chamber 2 L/min (more than 185 nm) 5 L/min (more than 180 nm)

*1 JASCO can provide Spectra Manager Ver. 2.5 CFR which is compliant with FDA 21 CFR PART 11 *2 These programs are provided with dedicated accessories.

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designed and manufactured by ISO-9001 and ISO-14001 certified JASCO Corporation



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